

Application/Control No.	Applicant(s)/Patent under Reexamination
10/023,346	LIPP, JOHN
Examiner	Art Unit
Tan V. Mai	2193

SEARCHED					
Class	Subclass	Date	Examiner		
updated	search	8/8/2006	MAI		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
PGPUB text search (see interference search printout)		8/8/2006	MAI	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated search (see printout)	8/8/2006	MAI		
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